

# PH3855L

N-channel TrenchMOS™ logic level FET

Rev. 01 — 26 January 2005

Product data sheet

## 1. Product profile

### 1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS™ technology.

### 1.2 Features

- Logic level threshold
- Surface mounted package.

### 1.3 Applications

- DC-to-DC converters
- Motors, lamps, solenoids
- General purpose power switching
- 12 V and 24 V loads.

### 1.4 Quick reference data

- $V_{DS} \leq 55$  V
- $R_{DS(on)} \leq 36$  m $\Omega$
- $I_D \leq 24$  A
- $Q_{gd} = 5.5$  nC (typ).

## 2. Pinning information

Table 1: Pinning

Pin	Description	Simplified outline	Symbol
1, 2, 3	source	<p>Top view</p> <p>SOT669 (LFAK)</p>	<p>mbb076</p>
4	gate		
mb	mounting base; connected to drain		

### 3. Ordering information

**Table 2: Ordering information**

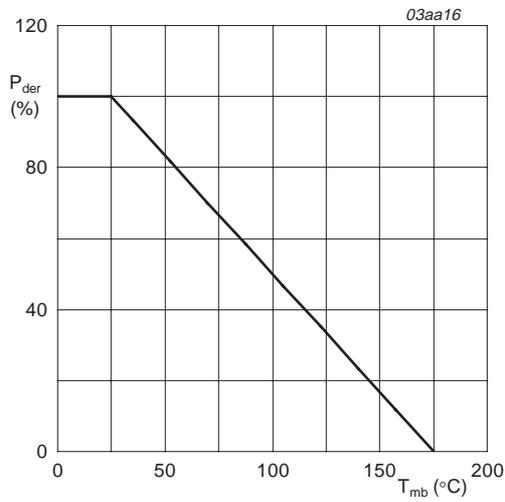
Type number	Package		Version
	Name	Description	
PH3855L	LFAK	plastic single-ended surface mounted package; 4 leads	SOT669

### 4. Limiting values

**Table 3: Limiting values**

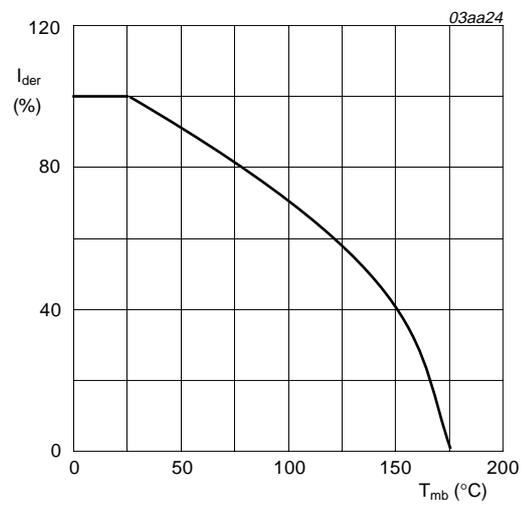
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage (DC)	$25\text{ °C} \leq T_j \leq 175\text{ °C}$	-	55	V
$V_{DGR}$	drain-gate voltage (DC)	$25\text{ °C} \leq T_j \leq 175\text{ °C}$ ; $R_{GS} = 20\text{ k}\Omega$	-	55	V
$V_{GS}$	gate-source voltage (DC)		-	$\pm 15$	V
$I_D$	drain current (DC)	$T_{mb} = 25\text{ °C}$ ; $V_{GS} = 5\text{ V}$ ; <a href="#">Figure 2</a> and <a href="#">3</a>	-	24	A
		$T_{mb} = 100\text{ °C}$ ; $V_{GS} = 5\text{ V}$ ; <a href="#">Figure 2</a>	-	17.2	A
$I_{DM}$	peak drain current	$T_{mb} = 25\text{ °C}$ ; pulsed; $t_p \leq 10\text{ }\mu\text{s}$ ; <a href="#">Figure 3</a>	-	45	A
$P_{tot}$	total power dissipation	$T_{mb} = 25\text{ °C}$ ; <a href="#">Figure 1</a>	-	50	W
$T_{stg}$	storage temperature		-55	+175	°C
$T_j$	junction temperature		-55	+175	°C
<b>Source-drain diode</b>					
$I_S$	source (diode forward) current (DC)	$T_{mb} = 25\text{ °C}$	-	24	A
$I_{SM}$	peak source (diode forward) current	$T_{mb} = 25\text{ °C}$ ; pulsed; $t_p \leq 10\text{ }\mu\text{s}$	-	45	A
<b>Avalanche ruggedness</b>					
$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	unclamped inductive load; $I_D = 30\text{ A}$ ; $t_p = 0.04\text{ ms}$ ; $V_{DD} \leq 55\text{ V}$ ; $R_{GS} = 50\text{ }\Omega$ ; $V_{GS} = 10\text{ V}$ ; starting at $T_j = 25\text{ °C}$	-	40	mJ



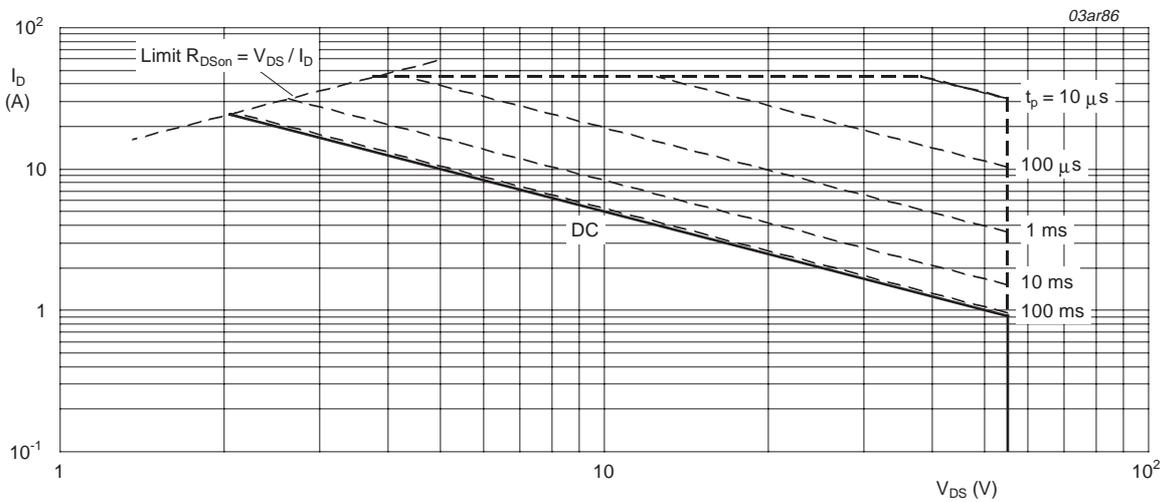
$$P_{der} = \frac{P_{tot}}{P_{tot(25^\circ C)}} \times 100\%$$

Fig 1. Normalized total power dissipation as a function of mounting base temperature.



$$I_{der} = \frac{I_D}{I_{D(25^\circ C)}} \times 100\%$$

Fig 2. Normalized continuous drain current as a function of mounting base temperature.



$T_{mb} = 25^\circ C$ ;  $I_{DM}$  is single pulse;  $V_{GS} = 5 V$

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage.

## 5. Thermal characteristics

Table 4: Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	Figure 4	-	-	3	K/W

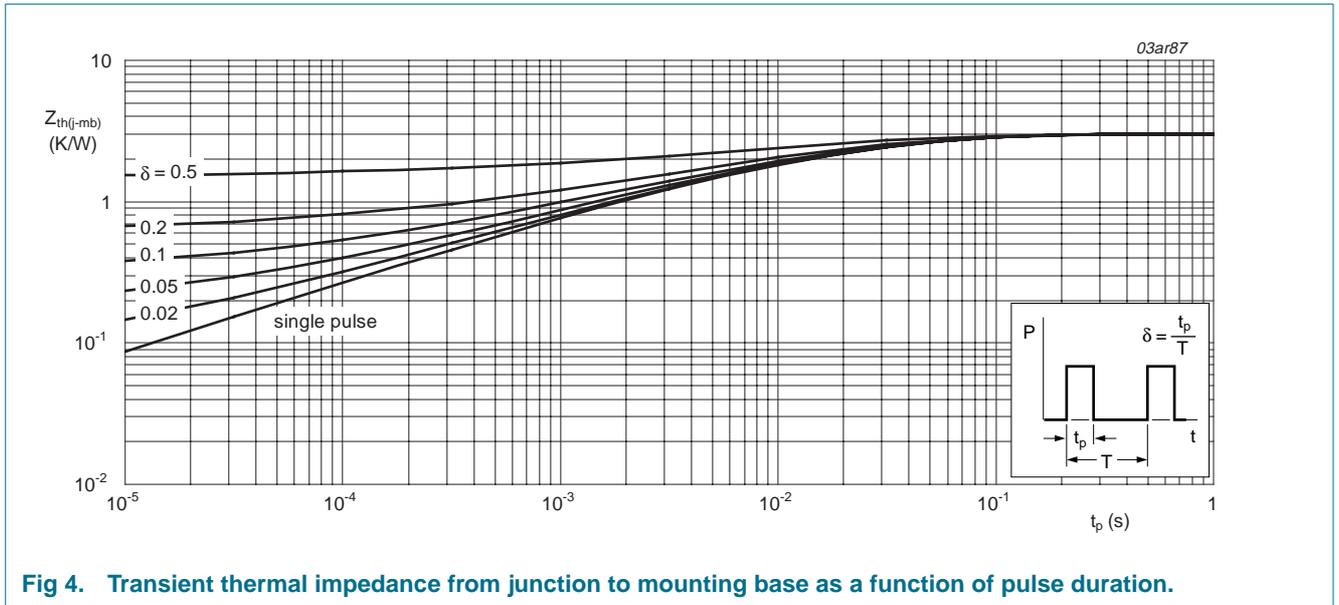
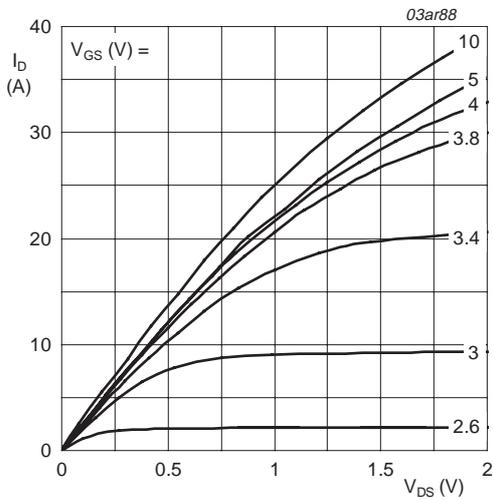


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration.

## 6. Characteristics

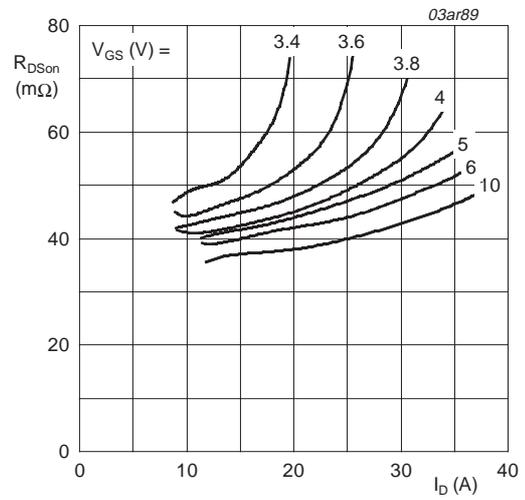
**Table 5: Characteristics**
*T<sub>j</sub> = 25 °C unless otherwise specified.*

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static characteristics</b>						
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	I <sub>D</sub> = 250 μA; V <sub>GS</sub> = 0 V T <sub>j</sub> = 25 °C T <sub>j</sub> = -55 °C	55	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	I <sub>D</sub> = 1 mA; V <sub>DS</sub> = V <sub>GS</sub> ; <a href="#">Figure 9</a> and <a href="#">10</a> T <sub>j</sub> = 25 °C T <sub>j</sub> = 175 °C T <sub>j</sub> = -55 °C	1	1.5	2	V
I <sub>DSS</sub>	drain-source leakage current	V <sub>DS</sub> = 55 V; V <sub>GS</sub> = 0 V T <sub>j</sub> = 25 °C T <sub>j</sub> = 175 °C	-	-	1	μA
I <sub>GSS</sub>	gate-source leakage current	V <sub>GS</sub> = ±15 V; V <sub>DS</sub> = 0 V	-	2	100	nA
R <sub>DS(on)</sub>	drain-source on-state resistance	V <sub>GS</sub> = 5 V; I <sub>D</sub> = 15 A; <a href="#">Figure 6</a> and <a href="#">8</a> T <sub>j</sub> = 25 °C T <sub>j</sub> = 175 °C V <sub>GS</sub> = 4.5 V; I <sub>D</sub> = 15 A; <a href="#">Figure 8</a> V <sub>GS</sub> = 10 V; I <sub>D</sub> = 15 A; <a href="#">Figure 6</a> and <a href="#">8</a>	-	34	40	mΩ
<b>Dynamic characteristics</b>						
Q <sub>g(tot)</sub>	total gate charge	I <sub>D</sub> = 15 A; V <sub>DS</sub> = 44 V; V <sub>GS</sub> = 5 V; <a href="#">Figure 11</a>	-	11.7	-	nC
Q <sub>gs</sub>	gate-source charge		-	2.5	-	nC
Q <sub>gd</sub>	gate-drain (Miller) charge		-	5.5	-	nC
C <sub>iss</sub>	input capacitance	V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 25 V; f = 1 MHz; <a href="#">Figure 13</a>	-	765	-	pF
C <sub>oss</sub>	output capacitance		-	125	-	pF
C <sub>rss</sub>	reverse transfer capacitance		-	70	-	pF
t <sub>d(on)</sub>	turn-on delay time	V <sub>DS</sub> = 30 V; R <sub>L</sub> = 2.2 Ω; V <sub>GS</sub> = 5 V; R <sub>G</sub> = 10 Ω	-	17	-	ns
t <sub>r</sub>	rise time		-	93	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	35	-	ns
t <sub>f</sub>	fall time		-	72	-	ns
<b>Source-drain diode</b>						
V <sub>SD</sub>	source-drain (diode forward) voltage	I <sub>S</sub> = 20 A; V <sub>GS</sub> = 0 V; <a href="#">Figure 12</a>	-	0.85	1.2	V
t <sub>rr</sub>	reverse recovery time	I <sub>S</sub> = 20 A; dI <sub>S</sub> /dt = -100 A/μs;	-	45	-	ns
Q <sub>r</sub>	recovered charge	V <sub>GS</sub> = 0 V; V <sub>R</sub> = 30 V	-	25	-	nC



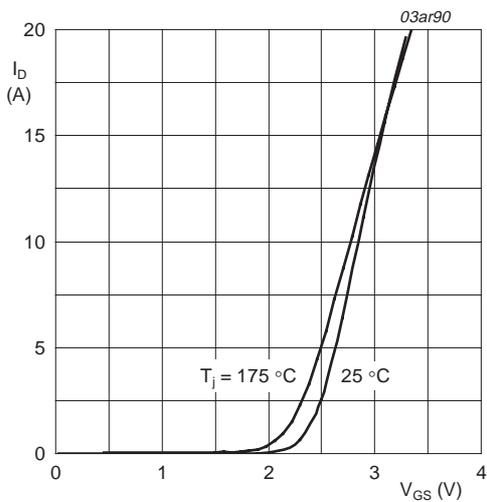
$T_j = 25\text{ }^\circ\text{C}$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values.



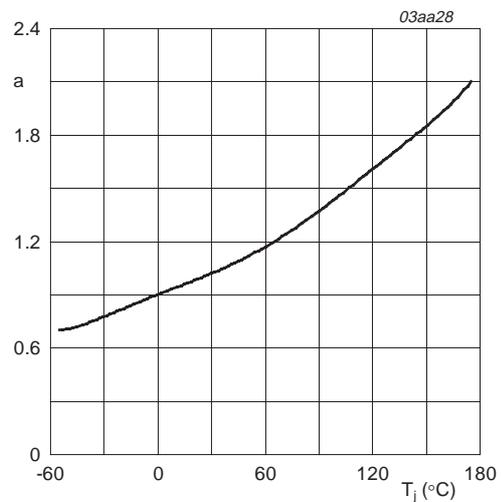
$T_j = 25\text{ }^\circ\text{C}$

Fig 6. Drain-source on-state resistance as a function of drain current; typical values.



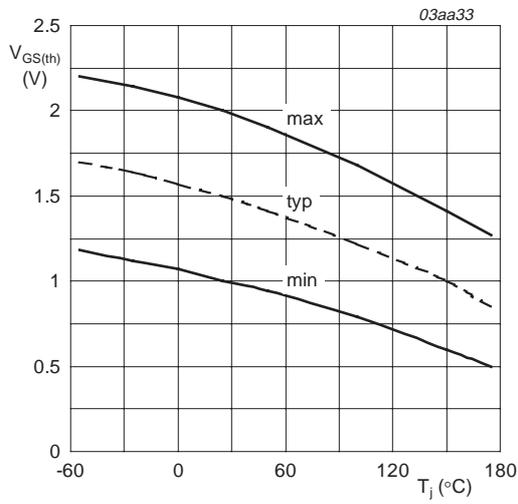
$T_j = 25\text{ }^\circ\text{C}$  and  $175\text{ }^\circ\text{C}$ ;  $V_{DS} > I_D \times R_{DS(on)}$

Fig 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values.



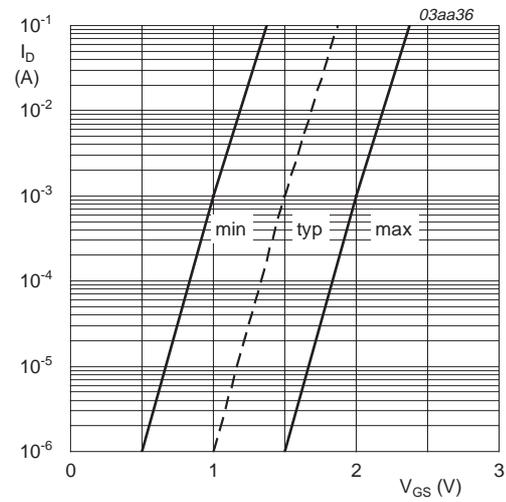
$$a = \frac{R_{DS(on)}}{R_{DS(on)(25\text{ }^\circ\text{C})}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature.



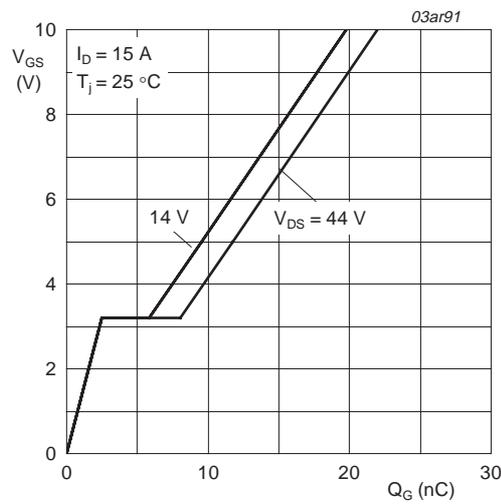
$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

Fig. 9. Gate-source threshold voltage as a function of junction temperature.



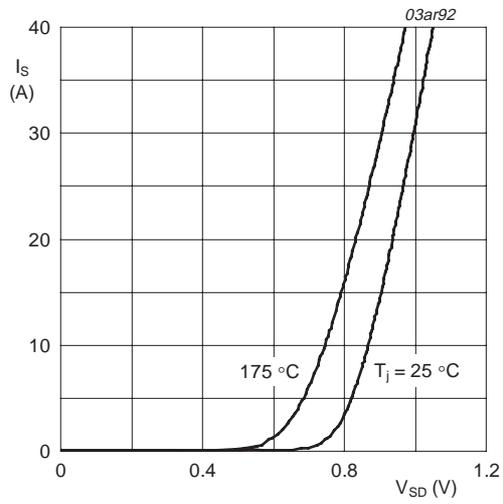
$T_j = 25 \text{ }^\circ\text{C}; V_{DS} = 5 \text{ V}$

Fig. 10. Sub-threshold drain current as a function of gate-source voltage.



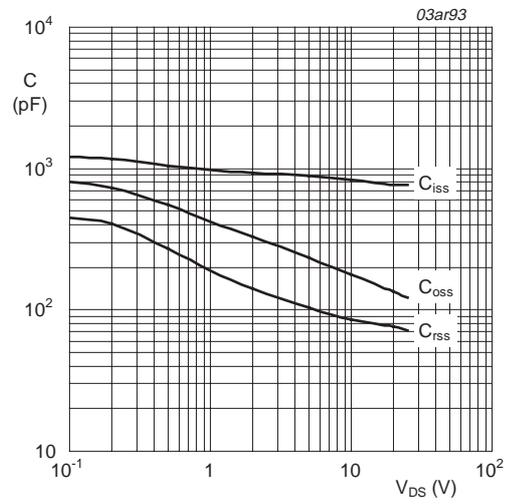
$I_D = 15 \text{ A}; V_{DS} = 14 \text{ V and } 44 \text{ V}$

Fig. 11. Gate-source voltage as a function of gate charge; typical values.



$T_j = 25\text{ °C}$  and  $175\text{ °C}$ ;  $V_{GS} = 0\text{ V}$

**Fig 12. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values.**



$V_{GS} = 0\text{ V}$ ;  $f = 1\text{ MHz}$

**Fig 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values.**

7. Package outline

Plastic single-ended surface mounted package (LPAK); 4 leads

SOT669

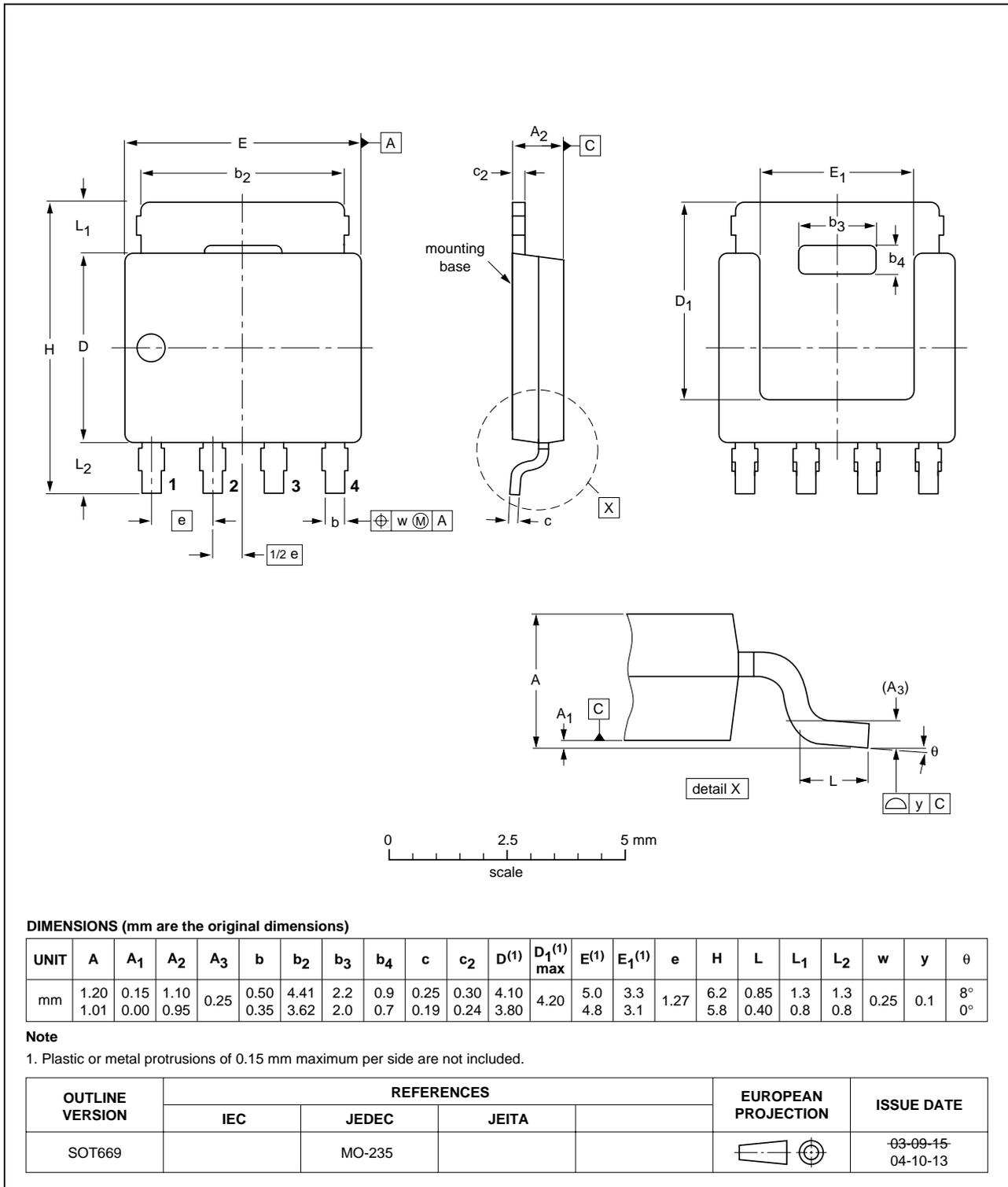


Fig 14. Package outline SOT669 (LPAK).

## 8. Revision history

Table 6: Revision history

Document ID	Release date	Data sheet status	Change notice	Doc. number	Supersedes
PH3855L_1	20050126	Product data sheet	-	9397 750 13925	-

## 9. Data sheet status

Level	Data sheet status <sup>[1]</sup>	Product status <sup>[2] [3]</sup>	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL <http://www.semiconductors.philips.com>.

[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

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**Short-form specification** — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

**Limiting values definition** — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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